**INSTRUMENTS** Data sheet acquired from Harris Semiconductor SCHS033A – Revised March 2002

FXAS

# **BCD-to-Decimal Decoder**

High-Voltage Types (20-Volt Rating)

CD4028B types are BCD-todecimal or binary-to-octal decoders consisting of buffering on all 4 inputs, decodinglogic gates, and 10 output buffers. A BCD code applied to the four inputs, A to D, results in a high level at the selected one of 10 decimal decoded outputs. Similarly, a 3-bit binary code applied to inputs A through C is decoded in octal code at output 0 to 7 if D = "0". High drive capability is provided at all outputs to enhance dc and dynamic performance in high fan-out applications.

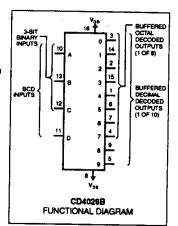
The CD4028B-Series types are supplied in 16-lead hermetic dual-in-line ceramic packages (D and F suffixes), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline package (NSR suffix), and in chip form (H suffix).

# Features:

- BCD-to-decimal decoding or binary-to-octal decoding
- High decoded output drive capability
- Positive logic" inputs and outputs....
  ..... decoded outputs go high on selection
- Medium-speed operation.... tpHL, tpLH = 80 ns (typ.) @ V<sub>DD</sub> = 10 V
- Standardized, symmetrical output characteristics
- 100% tested for guiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full package-temperature range; 100 nA at 18 V and 25<sup>o</sup>C
- Noise margin (over full packagetemperature range):
  - 1 V at V<sub>DD</sub> = 5 V
  - 2 V at V<sub>DD</sub> = 10 V
  - 2.5 V at V<sub>DD</sub> = 15 V
- 5-V, 10-V, and 15-V parametric ratings
   Meets all requirements of JEDEC
- Tentative Standard No. 138, "Standard Specifications for Description of 'B' Series CMOS Devices''

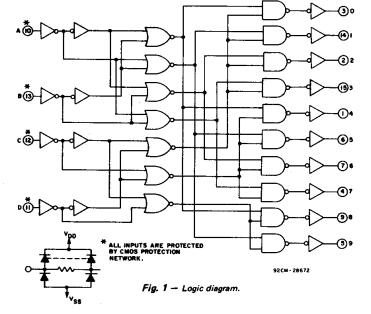
#### Applications:

- Code conversion
   Indicator-tube decoder
- Address decoding—memory selection control



	_
· • —   • `	- <b>16</b> ⊢ V <sub>DD</sub>
2 - 2	15 3
0	14 F i
7 -4	13 — в
9 5	12 - C
5 6	11 <b>b</b> - 0
6 - 7	10 <b>–</b> A
ss — e	9 - 8
L	
	9205-24471

Top View TERMINAL DIAGRAM



#### MAXIMUM RATINGS, Absolute-Maximum Values:

# TABLE I - TRUTH TABLE

		B	A	0	1	2	3	4	5	6	7	8	9
0	0	0	0	1	0	0	0	0	0	0	0	0	0
0	0	0	1	0	1	0	0	0	0	0	0	0	0
0	0	1	0	0	0	1	0	0	0	0	0	0	0
0	0	1	1	0	0	0	1	0	0	0	0	0	0
0	1	0	0	0	0	0	0	1	0	0	0	0	0
0	1	0	1	0	0	0	0	0	1	0	0	0	0
0	1	1	0	0	0	0	0	0	0	1	0	0	0
0	1	1	1	0	0	0	0	0	0	0	1	0	0
1	0	0	0	0	0	0	0	0	0	0	0	1	0
1	0	0	1	0	0	0	0	0	0	0	0	0	1
1	0	1	0	0	0	0	0	0	0	0	0	0	0
1	0	1	1	0	0	0	0	0	0	0	0	0	0
1	1	0	0	0	0	0	0	0	0	0	0	0	0
1	1	0	1	0	0	0	0	0	0	0	0	0	0
1	ł	1	0	0	0	0	0	0	0	0	0	0	0
1	1	1	1	0	0	0	0	0	0	0	0	0	0

# CD4028B Types

2

# **RECOMMENDED OPERATING CONDITIONS**

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

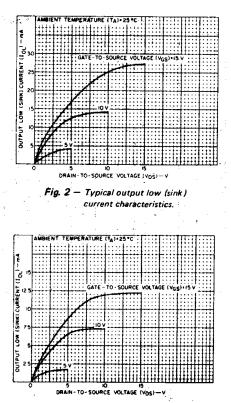
CHARACTERISTIC	LI	MITS	UNITS
	MIN.	MAX.	1
Supply Voltage Range (For T <sub>A</sub> = Full Package			
Temperature Range)	 3	18	۰ <b>v</b>

CHARACTER	CON	DITIO	NS	LIMI	LIMITS AT INDICATED TEMPERATURES (°C)										
ISTIC	Vo	VIN	VDD			-			+25		UNITS				
	(V)	(V)	(V)	-55	-40	+85	+125	Min.	Typ.	Max.	]				
Quiescent Device	-	0,5	5	5	5	150	150	- :	0.04	5					
Current,	-	0,10	10	10	10	300	300	<u> </u>	.0.04	10	1.				
IDD Max.	-	0,15	15	20	20	600	600		0.04	20	μΑ				
	-	0,20	20	100	100	3000	3000	-	0.08	100	1				
Output Low	0.4	0,5	5	0.64	0.61	0.42	0,36	0.51	1	<u> </u>	t				
(Sink) Current	0,5	0,10	10	1.6	1.5	1,1	0.9	1.3	2.6		1				
IOL Min.	1,5	0,15	15	4.2	4	2.8	2.4	34	6.8	-	1 . ·				
Output High	4.6	0,5	5	-0.64	-0,61	-0.42	-0.36	-0.51	1	-	mA				
(Source)	2.5	0,5	· 5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	- 1	1				
Current, IOH Min,	9.5	0,10	10	- 1.6	-1,5	-1.1	-0.9	-1.3	-2.6	- 1	f				
	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	- 6.8	-					
Output Voltage:	-	0,5	5		0	.05		-	0	0.05					
Output Voltage: Low-Level, VOL Max.	_	0,10	10		0	.05		-	0	0.05					
•UL !!!!!	-	0,15	15		0	05		-	0	0.05	v				
Output Voltage:	-	0,5	5		4.	.95	-	4.95	5	-	7 Y				
High Level. VOH Min.	-	0,10	10		9.	95		9.95	10	-					
VOH MINI	-	0,15	15		14	.95		14.95	15	-					
Input Low	0.5, 4.5	-	5		1	.5		_	-	1.5					
Voltage, Vii Max,	1, 9	-	10			3		-		3					
	1.5,13.5	-	15			4		ł	-	4					
Input High	0.5, 4,5	-	5		3	.5		3,5	-	-	V				
Voltage,	1, 9	-	10			7		7	-	-					
VIH Min.	1.5,13.5	-	15		1	1		11	-	-					
Input Current IIN Max.	-	0,18	18	±0,1	±0.1	±1	±1	-	±10 <sup>-5</sup>	±0.1	μA				

# STATIC ELECTRICAL CHARACTERISTICS



CHARACTERISTIC	TEST CONDITIONS	LIM	UNITS			
	V <sub>DD</sub> (V)	Тур.	Тур. Мах.			
Propagation Delay Time:	5	175	350	ns		
<sup>t</sup> PHL <sup>, t</sup> PLH	10	80	160			
	15	60	120			
	5	100	200	1		
Transition Time	10	50	100	ns		
<sup>t</sup> THL <sup>, t</sup> TLH	15	40	80			
Input Capacitance, C <sub>IN</sub>	_	5	7.5	pF		



3

COMMERCIAL CMOS HIGH VOLTAGE ICS

Fig. 3 — Minimum output low (sink) current characteristics.

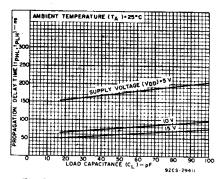


Fig. 4 — Typical propagation delay time as a function of load capacitance.

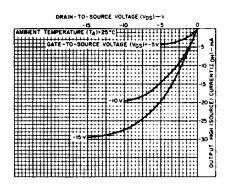


Fig. 5 – Typical output high (source) current characteristics.

## **TABLE II - CODE CONVERSION CHART**

Γ				INPUT CODES								_													
Hexa - Decimal					D	ecima	)																		
1	INPUTS			IT IARY	AY .	EXCESS-3	EXCESS-3 GRAY	AIKEN	4221					I	ou	TP	UT	N	JM	BE	R				
D	С	B	A	481 BIN	<b>4</b> 6 R/	ŭ	26	Ī	42	0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15
0	0	0	0	0	0			0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
0	0	0	1	1	1			1	1	0	1	Ô,	0	0	0	0	0	0	0	0	0	0	0	0	0
0	0	1	0	2	3		0	2	2	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0
0	0	1	1	3	2	0	3	3		0	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0
0	1	0	0	4	7	1	4	4		0	0	0	0	1	0	0	0	0	Ó	0	0	0	0	0	0
0	1	0	1	5	6	2			3	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0	0
0	1	1	0	6	4	3	1		4	0	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0
0	1	1	1	7	5	4	2			0	0	0	0	0	0	0	1	0	0	0	0	0	0	0	0
1	0	0	0	8	15	5				0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0
1	0	0	1	9	14	6			5	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0
1	0	1	0	10	12	7	9		6	0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0
1	0	1	1	11	13	8		5		0	0	0	0	0	0	Ó	0	0	0	0	1	0	0	0	0
1	1	0	0	12	8	9	5	6		0	0	0	0	0	0	0	0	0	0	0	0	1	0	0	0
1	1	0	1	13	9		6	7	7	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
1	1	1	0	14	11		8	8	8	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0
1	1	1	1	15	10		7	9	9	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1

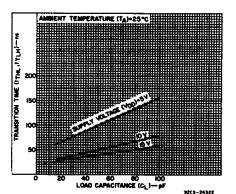


Fig. 8 — Typical transition time as a function of load capacitance.

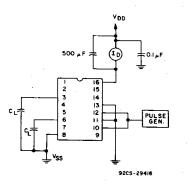


Fig. 10 - Dynamic power dissipation test circuit.

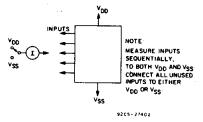


Fig. 9 - Input current test circuit.

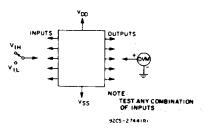
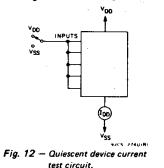
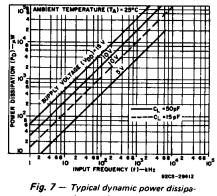


Fig. 11 - Input voltage test circuit.



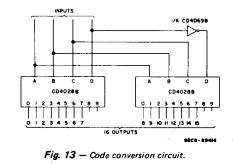
DRAIN-TO-SOURCE VOLTAGE (VD3)-V -15 -0 -9 0 -16 -0 -9 0 -17 -0 -9 0 -18 -0 -9 0 -10 -9 0 -

Fig. 6 — Minimum output high (source) current characteristics.

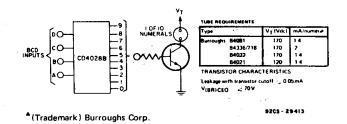


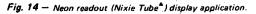
tion as a function of input frequency.

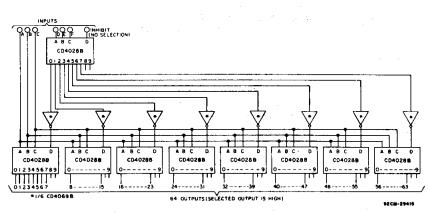
### TYPICAL APPLICATIONS

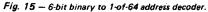


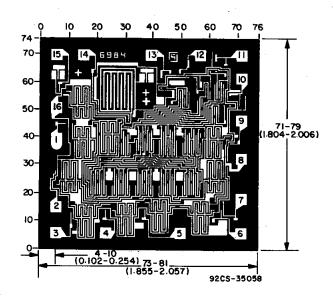
The circuit shown in Fig.13 converts any 4bit code to a decimal or hexadecimal code. Table 2 shows a number of codes and the decimal or hexadecimal number in these codes which must be applied to the input terminals of the CD4028B to select a particular output. For example: in order to get a high on output No. 8 the input must be either an 8 expressed in 4-Bit Binary code, a 15 expressed in 4-Bit Gray code, or a 5 expressed in Excess-3 code.











CD4028BH DIMENSIONS AND PAD LAYOUT

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils  $(10^{-3} \text{ inch})$ .

# **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third–party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Mailing Address:

Texas Instruments Post Office Box 655303 Dallas, Texas 75265

Copyright © 2002, Texas Instruments Incorporated